

<p style="text-align: center;">Sheet 1 of 1 SECOND IDS LIST OF REFERENCES CITED BY APPLICANT (FORM PTO-1449) DATED: November 7, 2005 O I P E</p>				Atty. Docket No.: 4685		Serial No.: 10/829,306		
				Applicant: Shinsuke FUJIWARA et al.				
				U.S. Filing Date: April 20, 2004		Art Unit: 2811		
U. S. PATENT DOCUMENTS								
*EXAMINER INITIALS	SEARCHED INDEXED MAILED	DOCUMENT NO.	DATE	NAME		Cl.	Sub-Cl.	Fil. Date
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NO.	DATE	COUNTRY	Cl.	Sub-Cl.	English	
NNL	AC	07-321409	12/1995	Japan	-	-	Abstract	
NNL	AD	09-293937	11/1997	Japan	-	-	Abstract	
OTHER DOCUMENTS								
EXAMINER'S SIGNATURE				DATE CONSIDERED				
<i>KangNanhee</i>				1-9-05				
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